

Sunday 30.8.2009.

17.20-18.30	Registration & Welcome party
18.30-19.30	M. Losurdo "Curiosities about ellipsometry"

Monday 31.8.2009.

9.00-10.00	E.A. Irene "Fundamentals of Ellipsometry"
10.05-11.05	K. Hingerl "Optical properties of materials"
	<i>Coffe break</i>
11.20-12.20	K. Hingerl "Propagation of light in layered materials"
	<i>Lunch break</i>
15.00-16.00	J. Humlicek "Polarization of light"
16.05-17.05	D. Khveshchenko "Doing photonics with Dirac fermions in graphene"
	<i>Coffee break</i>
17.20-19.30	Poster session & Measurements session

Tuesday 1.9.2009.

9.00-10.00	J. Humlicek "Continuum approach to the optical response of nanomixtures"
10.05-11.05	E.A. Irene "Ellipsometry Modeling"
	<i>Coffe break</i>
11.20-12.20	A. de Martino "Instrumentation in ellipsometry and polarimetry"
	<i>Lunch break</i>
14.00-16.30	Excursion and Belgrade sight seeing
	<i>Coffee break</i>
17:30-19:30	Measurements session

Wednesday 2.9.2009.

Thursday 3.9.2009.

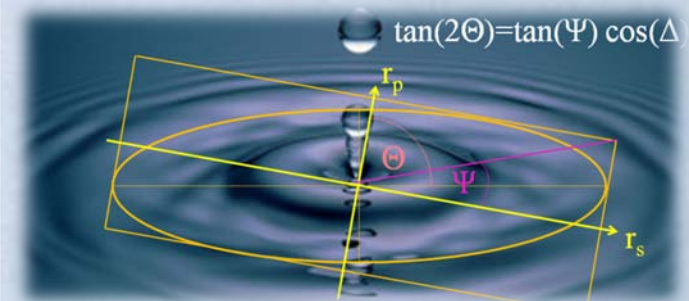
9.00-10.00	N. Esser "Reflection Anisotropy Spectroscopy at Surfaces and Nanostructures"
10.05-11.05	A. Laskarakis "In-situ and ex-situ Spectroscopic Ellipsometry for the study of state-of-the-art materials for flexible organic electronics applications"
	<i>Coffe break</i>
11.20-12.20	R. Gajić "Ellipsometry and Correlation Techniques"
	E. Bortchagovsky "Ellipsometry of thin films"
	<i>Lunch break</i>
15.00-16.00	Horiba JY "Round table"
16.05-17.05	Visit to the Institute of Physics
17.10-18.30	Measurements session
20:00-	Sight seeing by boat and conference dinner

9.00-10.00	A. de Martino "Optical metrology on submicrometer gratings"
10.05-11.05	S. Logothetidis "Spectroscopic Ellipsometry for Nanobiology and Nanomedicine applications"
	<i>Coffe break</i>
11.20-12.20	M. Gartner "In-situ Real Time Spectroscopic Ellipsometry - a powerful tool for monitoring the formation of QDs"
	<i>Lunch break</i>
15.00-15.25	R. Seitz "Basics on organic films by ellipsometry (FUV-VIS)"
15:25-15:50	M. Stchakovsky "An example of modeling of organic sample with DeltaPsi2 modeling software"
15:50-16:15	K. Hinrichs "FTIR ellipsometry for Organic thin films "
16.20-17.20	Horiba JY "Industrial ellipsometric applications: market trends and perspectives"

NANOELLI09 2nd NanoCharM European School on Ellipsometry

*Fundamentals and Applications in
Nanoscience and Nanotechnology*

Conference program



August 31st - September 3rd 2009
Belgrade, Serbia